

Search Notes

Application/Control No.

09/821,754

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

SCHMID ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
713	200	8/17/2005	ECT
713	159	8/17/2005	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES, IEEE	8/17/2005	ECT